Search Notes		

-	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/711,671	CHIU, YAO-CHENG	
	Examiner	Art Unit	
	Kim T. Huynh	2112	

SEARCHED				
Class	Subclass	Date	Examiner	
710	305-306	6/21/2006	КН	
710	100	6/21/2006	KH	
711	103	6/21/2006	КН	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
710	306	11/15/2006	КН		
710	100	11/15/2006	кн		
710	103	11/15/2006	КН		

SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
East search uspat; uspgpub; epo; jpo; derwent	6/21/2006	KH
updated prior search	11/15/2006	КН